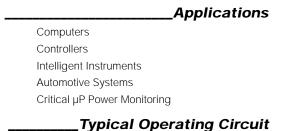
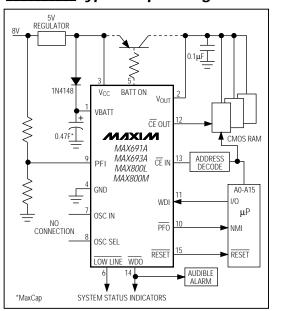
Warning

### General Description

The MAX691A/MAX693A/MAX800L/MAX800M microprocessor ( $\mu$ P) supervisory circuits are pin-compatible upgrades to the MAX691, MAX693, and MAX695. They improve performance with 30 $\mu$ A supply current, 200ms typ reset active delay on power-up, and 6ns chipenable propagation delay. Features include write protection of CMOS RAM or EEPROM, separate watchdog outputs, backup-battery switchover, and a RESET output that is valid with V<sub>CC</sub> down to 1V. The MAX691A/MAX800L have a 4.65V typical reset-threshold voltage, and the MAX693A/MAX800M's reset threshold is 4.4V typical. The MAX800L/MAX800M guarantee power-fail accuracies to  $\pm$ 2%.





### \_\_\_Features

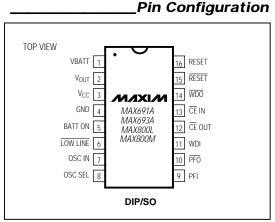
- 200ms Power-OK/Reset Timeout Period
- 1µA Standby Current, 30µA Operating Current
- On-Board Gating of Chip-Enable Signals, 10ns Max Delay
- MaxCap<sup>™</sup> or SuperCap<sup>™</sup> Compatible
- Guaranteed RESET Assertion to V<sub>CC</sub> = 1V
- Voltage Monitor for Power-Fail or Low-Battery
- Power-Fail Accuracy Guaranteed to ±2% (MAX800L/M)
- Available in 16-Pin Narrow SO and Plastic DIP Packages

### \_Ordering Information

TEMP. RANGE	PIN-PACKAGE
0°C to +70°C	16 Plastic DIP
0°C to +70°C	16 Narrow SO
0°C to +70°C	16 Wide SO
0°C to +70°C	Dice*
-40°C to +85°C	16 Plastic SO
-40°C to +85°C	16 Narrow SO
-40°C to +85°C	16 Wide SO
-40°C to +85°C	16 CERDIP
-55°C to +125°C	16 CERDIP
	0°C to +70°C 0°C to +70°C 0°C to +70°C 0°C to +70°C -40°C to +85°C -40°C to +85°C -40°C to +85°C -40°C to +85°C -40°C to +85°C

**Ordering Information continued on last page.** \* Dice are specified at  $T_A = +25$  °C.





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### M/IXI/M

Maxim Integrated Products 1

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## ABSOLUTE MAXIMUM RATINGS

Terminal Voltage (with respect to GND)	Continuous Power Dissipation ( $T_A = +70^{\circ}C$ )
V <sub>CC</sub> 0.3V to +6V	Plastic DIP (derate 10.53mW/°C above +70°C)842mW
VBATT0.3V to +6V	Narrow SO (derate 8.70mW/°C above +70°C)696mW
All Other Inputs0.3V to (V <sub>OUT</sub> + 0.3V)	Wide SO (derate 9.52mW/°C above +70°C)
Input Current	CERDIP (derate 10.00mW/°C above +70°C)800mW
V <sub>CC</sub> Peak1.0A	Operating Temperature Ranges
V <sub>CC</sub> Continuous250mA	MAX69_AC/MAX800_C0°C to +70°C
VBĂTT Peak250mA	MAX69_AE/MAX800_E40°C to +85°C
VBATT Continuous25mA	MAX69_AMJE55°C to +125°C
GND, BATT ON100mA	Storage Temperature Range65°C to +160°C
All Other Outputs25mA	Lead Temperature (soldering, 10sec)+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### **ELECTRICAL CHARACTERISTICS**

(MAX691A, MAX800L: V<sub>CC</sub> = 4.75V to 5.5V, MAX693A, MAX800M: V<sub>CC</sub> = 4.5V to 5.5V, VBATT = 2.8V, T<sub>A</sub> = T<sub>MIN</sub> to T<sub>MAX</sub>, unless otherwise noted.)

PARAMETER	C	ONDITIONS		MIN	TYP	MAX	UNITS	
Operating Voltage Range, V <sub>CC</sub> , VBATT (Note 1)				0		5.5	V	
		I <sub>OUT</sub> = 25mA		V <sub>CC</sub> - 0.05	V <sub>CC</sub> - 0.02			
V <sub>OUT</sub> Output	$V_{CC} = 4.5V$	I <sub>OUT</sub> = 250mA	MAX69_AC/AE, MAX800_C/E	V <sub>CC</sub> - 0.3	V <sub>CC</sub> - 0.2		V	
			MAX69_AM	V <sub>CC</sub> - 0.40				
V <sub>CC</sub> -to-V <sub>OUT</sub> On-Resistance	MAX69_AC/AE, N	, MAX800_C/E		0.8	1.2	Ω		
VCC-IO-VOUT ON-RESISIANCE	VCC = 4.5V	MAX69_AM			0.8	1.6	- 12	
	VBATT = 4.5V, IOUT	= 20mA		VBATT - 0.3	}			
V <sub>OUT</sub> in Battery-Backup Mode	VBATT = 2.8V, IOUT	= 10mA		VBATT - 0.2	25		V	
mode	VBATT = 2.0V, IOUT	= 5mA		VBATT - 0.1	5			
	VBATT = 4.5V					15		
VBATT-to-V <sub>OUT</sub> On-Resistance	VBATT = 2.8V					25	Ω	
on resistance	VBATT = 2.0V					30	1	
Supply Current in Normal Operating Mode (Excludes I <sub>OUT</sub> )	V <sub>CC</sub> > VBATT - 1V				30	100	μA	
Supply Current in	V <sub>CC</sub> < VBATT - 1.2V	$T_A = +25^{\circ}C$			0.04	1		
Battery-Backup Mode (Excludes I <sub>OUT</sub> ) (Note 2)	VBATT = 2.8V	$T_A = T_{MIN} + T_N$	/IN			5	- μΑ	
VBATT Standby Current		T <sub>A</sub> = +25°C		-0.1		0.02		
(Note 3)	$VBATT + 0.2V \le V_{CC}$	$T_A = T_{MIN} + T_N$	/IN	-1.0		0.02	- μΑ	
Battery Switchover	Power-up				VBATT + 0.3		V	
Threshold	Power-down				VBATT - 0.3		v	
Battery Switchover Hysteresis					60		mV	
BATT ON Output I <sub>SINK</sub> = 3.2mA					0.1	0.4	v	
Low Voltage	I <sub>SINK</sub> = 25mA				0.7	1.5		
BATT ON Output	BATT ON Output Sink current			60		mA		
Short-Circuit Current	Source current			1	15	100	μA	

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### **ELECTRICAL CHARACTERISTICS (continued)**

(MAX691A, MAX800L:  $V_{CC}$  = 4.75V to 5.5V, MAX693A, MAX800M:  $V_{CC}$  = 4.5V to 5.5V, VBATT = 2.8V,  $T_A$  =  $T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.)

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS	
RESET AND WATCHDOG TIMER						
	MAX691A, MAX800L	4.50	4.65	4.75		
	MAX693A, MAX800M	4.25	4.40	4.50	v	
Reset Threshold Voltage	MAX800L, $T_A = +25^{\circ}C$ , $V_{CC}$ falling 4.55			4.70		
	MAX800M, $T_A = +25^{\circ}C$ , V <sub>CC</sub> falling	4.30		4.45		
Reset Threshold Hysteresis			15		mV	
V <sub>CC</sub> to RESET Delay	Power-down		80		μs	
LOWLINE-to-RESET Delay			800		ns	
Reset Active Timeout Period, Internal Oscillator	Power-up	140	200	280	ms	
Reset Active Timeout Period, External Clock (Note 4)	Power-up		2048		Clock Cycles	
Watchdog Timeout Period,	Long period	1.0	1.6	2.25	sec	
Internal Oscillator	Short Period	70	100	140	ms	
Watchdog Timeout Period,	Long Period		4096		Clock	
External Clock (Note 4)	Short Period		1024		Cycles	
Minimum Watchdog Input Pulse Width	V <sub>IL</sub> = 0.8V, V <sub>IH</sub> = 0.75 x V <sub>CC</sub>	100			ns	
	$I_{SINK} = 50\mu A$ , $V_{CC} = 1V$ , $VBATT = 0V$ , $V_{CC}$ falling		0.004	0.3	V	
RESET Output Voltage	ISINK = 3.2mA, V <sub>CC</sub> = 4.25V		0.1	0.4		
	$I_{SOURCE} = 1.6 \text{mA}, V_{CC} = 5 \text{V}$	3.5				
RESET Output Short-Circuit Current	Output source current		7	20	mA	
RESET Output Voltage Low (Note 5)	Isink = 3.2mA	0.1	0.4		V	
LOW LINE Output Voltage	I <sub>SINK</sub> = 3.2mA, V <sub>CC</sub> = 4.25V			0.4	V	
LOW LINE Output voltage	$I_{SOURCE} = 1 \mu A, V_{CC} = 5 V$	3.5			v	
LOW LINE Output Short-Circuit Current	Output source current	1	15	100	μΑ	
	I <sub>SINK</sub> = 3.2mA			0.4	<u> </u>	
WDO Output Voltage	$I_{SOURCE} = 500 \mu A, V_{CC} = 5 V$	3.5			V	
WDO Output Short-Circuit Current	Output source current		3	10	mA	
WDI Threshold Voltage	VIH	0.75 x V <sub>CC</sub>			V	
(Note 6)	VIL			0.8	V	
	WDI = 0V	-50	-10		μΑ	
WDI Input Current	WDI = V <sub>OUT</sub>		20	50		

MAX691A/MAX693A/MAX800L/MAX800M

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### **ELECTRICAL CHARACTERISTICS (continued)**

(MAX691A, MAX800L:  $V_{CC}$  = 4.75V to 5.5V, MAX693A, MAX800M:  $V_{CC}$  = 4.5V to 5.5V, VBATT = 2.8V,  $T_A$  =  $T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.)

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS	
POWER-FAIL COMPARATOR	1					
	MAX69_AC/AE/AM, $V_{CC} = 5V$	1.2	1.25	1.3	v	
PFI Input Threshold	MAX800_C/E, V <sub>CC</sub> = 5V	1.225	1.25	1.275	1 <sup>v</sup>	
PFI Leakage Current			±0.01	±25	nA	
	I <sub>SINK</sub> = 3.2mA			0.4	v	
PFO Output Voltage	$I_{SOURCE} = 1\mu A, V_{CC} = 5V$	3.5			1 <sup>v</sup>	
PFO Output Short-Circuit Current	Output source current	1	15	100	μA	
	$V_{IN} = -20mV, V_{OD} = 15mV$		25			
PFI-to-PFO Delay	$V_{IN} = 20mV$ , $V_{OD} = 15mV$		60		μs	
CHIP-ENABLE GATING	1	1				
CE IN Leakage Current	Disable mode		±0.005	±1	μA	
CE IN-to-CE OUT Resistance (Note 7)	Enable mode		75	150	Ω	
CE OUT Short-Circuit Current (Reset Active)	Disable mode, CE OUT = 0V	0.1	0.75	2.0	mA	
CE IN-to-CE OUT Propagation Delay (Note 8)	50Ω source impedance driver, C <sub>LOAD</sub> = 50pF		6	10	ns	
CE OUT Output Voltage High	V <sub>CC</sub> = 5V, I <sub>OUT</sub> = -100µA	3.5			v	
(Reset Active)	$V_{CC} = 0V$ , VBATT = 2.8V, $I_{OUT} = 1\mu A$	2.7			1 <sup>v</sup>	
RESET-to-CE OUT Delay	Power-down		12		μs	
INTERNAL OSCILLATOR	1					
OSC IN Leakage Current	OSC SEL = 0V		0.10	±5	μA	
OSC IN Input Pull-Up Current	OSC SEL = V <sub>OUT</sub> or floating, OSC IN = 0V		10	100	μΑ	
OSC SEL Input Pull-Up Current	OSC SEL = 0V		10	100	μΑ	
OSC IN Frequency Range	OSC SEL = 0V		50		kHz	
OSC IN External Oscillator	VIH	V <sub>OUT</sub> - 0.4	V <sub>OUT</sub> - 0.6		V	
Threshold Voltage	VIL		3.65	2.00	v	
OSC IN Frequency with External Capacitor	OSC SEL = 0V, COSC = 47pF		100		kHz	

**Note 1:** Either V<sub>CC</sub> or VBATT can go to 0V, if the other is greater than 2.0V.

Note 2: The supply current drawn by the MAX691A/MAX800L/MAX800M from the battery excluding  $I_{OUT}$  typically goes to 10µA when (VBATT - 1V) < V<sub>CC</sub> < VBATT. In most applications, this is a brief period as V<sub>CC</sub> falls through this region.

Note 3: "+" = battery-discharging current, "-" = battery-charging current.

Note 4: Although presented as typical values, the number of clock cycles for the reset and watchdog timeout periods are fixed and do not vary with process or temperature.

Note 5: RESET is an open-drain output and sinks current only.

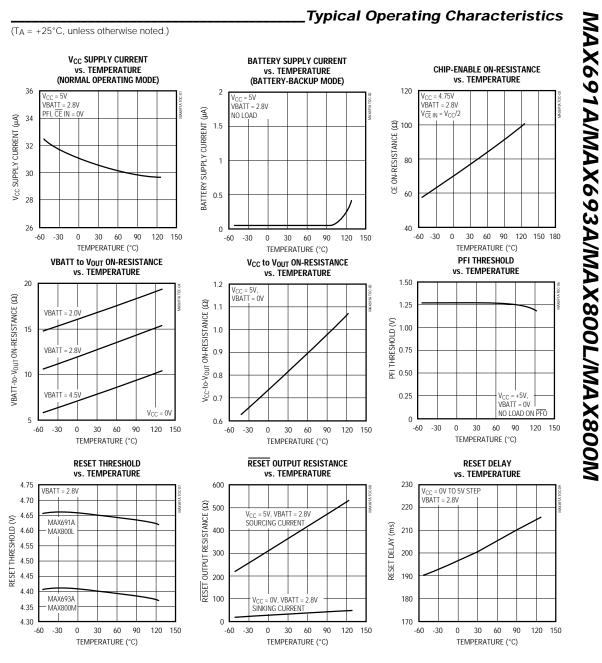
Note 6: WDI is internally connected to a voltage divider between V<sub>OUT</sub> and GND. If unconnected, WDI is driven to 1.6V (typ), disabling the watchdog function.

Note 7: The chip-enable resistance is tested with V<sub>CC</sub> = 4.75V for the MAX691A/MAX800L and V<sub>CC</sub> = 4.5V for the MAX693A/MAX800M.  $\overline{CE}$  IN =  $\overline{CE}$  OUT = V<sub>CC</sub> / 2.

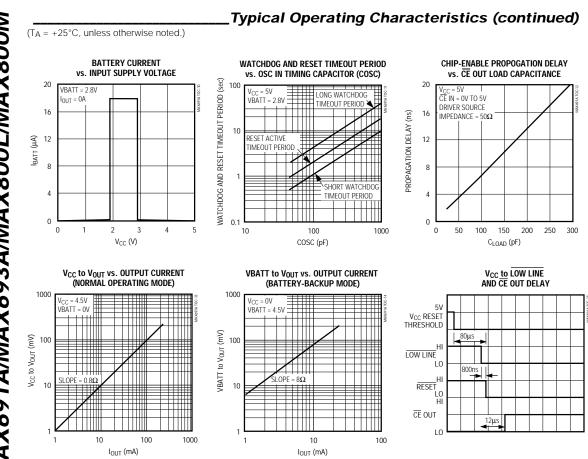
Note 8: The chip-enable propagation delay is measured from the 50% point at CE IN to the 50% point at CE OUT.

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MAX691A/MAX693A/MAX800L/MAX800M

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PIN	NAME	FUNCTION					
1	VBATT	Battery-Backup Input. Connect to external battery or capacitor and charging circuit. If backup battery is not used, connect to GND.					
2	V <sub>OUT</sub>	capacitor from V <sub>OUT</sub> to GND. Connect V <sub>OUT</sub> to V <sub>CC</sub> if no backup battery is used.					
3	V <sub>CC</sub>	Input Supply Voltage, 5V input.					
4	GND	Ground. 0V reference for all signals.					
5	BATT ON	Battery On Output. When $V_{OUT}$ switches to VBATT, BATT ON goes high. When $V_{OUT}$ switches to $V_{CC}$ , BATT ON goes low. Connect the base of a PNP through a current-limiting resistor to BATT ON for $V_{OUT}$ current requirements greater than 250mA.					
6	LOW LINE	$\overline{\text{LOW LINE}}$ output goes low when V <sub>CC</sub> falls below the reset threshold. It returns high as soon as V <sub>CC</sub> rises above the reset threshold.					
7	OSC IN	External Oscillator Input. When OSC SEL is unconnected or driven high, a $10\mu$ A pull-up connects from V <sub>OUT</sub> to OSC IN, the internal oscillator sets the reset and watchdog timeout periods, and OSC IN selects between fast and slow watchdog timeout periods. When OSC SEL is driven low, the reset and watchdog timeout periods may be set either by a capacitor from OSC IN to ground or by an external clock at OSC IN (see Figure 3.)					
8	OSC SEL	Oscillator Select. When OSC SEL is unconnected or driven high, the internal oscillator sets the reset delay and watchdog timeout period. When OSC SEL is low, the external oscillator input (OSC IN) is enabled (see Table 1). OSC SEL has a 10µA internal pull-up.					
9	PFI	Power Fail Input. This is the perinverting input to the newer fail comparator. When PEL is less than 1.25V, PE					
10	PFO Power-Fail Output. This is the output of the power-fail comparator. PFO goes low when PFI is less than 1.25   This is an uncommitted comparator, and has no effect on any other internal circuitry.						
11	WDI	Watchdog Input. WDI is a three-level input. If WDI remains either high or low for longer than the watchdog time- out period, WDO goes low and reset is asserted for the reset timeout period. WDO remains low until the next tran- sition at WDI. Leaving WDI unconnected disables the watchdog function. WDI connects to an internal voltage divider between V <sub>OUT</sub> and GND, which sets it to mid-supply when left unconnected.					
12	CE OUT	Chip-Enable Output. $\overline{CE}$ OUT goes low only when $\overline{CE}$ IN is low and V <sub>CC</sub> is above the reset threshold. If CE IN is low when reset is asserted, $\overline{CE}$ OUT will stay low for 15µs or until $\overline{CE}$ IN goes high, whichever occurs first.					
13	CE IN	Chip-Enable Input. The input to chip-enable gating circuit. If CE IN is not used, connect CE IN to GND or VOUT.					
14	WDO	Watchdog Output. If WDI remains high or low longer than the watchdog timeout period, WDO goes low and reset is asserted for the reset timeout period. WDO returns high on the next transition at WDI. WDO remains high if WDI is unconnected.					
15	RESET	RESET Output goes low whenever $V_{CC}$ falls below the reset threshold. RESET will remain low typically for 200ms after $V_{CC}$ crosses the reset threshold on power-up.					
16	RESET	RESET is an active-high output. It is open drain, and the inverse of RESET.					

# MAX691A/MAX693A/MAX800L/MAX800M

# \_\_Detailed Description

### **RESET** and **RESET** Outputs

The MAX691A/MAX693A/MAX800L/MAX800M's RESET and RESET outputs ensure that the  $\mu$ P (with reset inputs asserted either high or low) powers up in a known state, and prevents code-execution errors during power-down or brownout conditions.

The RESET output is active low, and typically sinks 3.2mA at 0.1V saturation voltage in its active state. When deasserted, RESET sources 1.6mA at typically  $V_{OUT}$  - 0.5V. RESET output is open drain, active high, and typically sinks 3.2mA with a saturation voltage of 0.1V. When no backup battery is used, RESET output is

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guaranteed to be valid down to  $V_{CC}$  = 1V, and an external 10k $\Omega$  pull-down resistor on RESET insures that it will be valid with  $V_{CC}$  down to GND (Figure 1). As  $V_{CC}$  goes below 1V, the gate drive to the RESET output switch reduces accordingly, increasing the  $r_{DS(ON)}$  and the saturation voltage. The 10k $\Omega$  pull-down resistor insures the parallel combination of switch plus resistor is around 10k $\Omega$  and the output saturation voltage is below 0.4V while sinking 40µA. When using a 10k $\Omega$  external pull-down resistor, the high state for RESET output with  $V_{CC}$  = 4.75V will be 4.5V typical. For battery voltages  $\geq$  2V connected to VBATT, RESET and RESET remain valid for  $V_{CC}$  from 0V to 5.5V.

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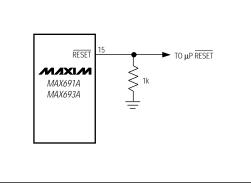


Figure 1. Adding an external pull-down resistor ensures  $\overrightarrow{RESET}$  is valid with V<sub>CC</sub> down to GND.

RESET and RESET are asserted when V<sub>CC</sub> falls below the reset threshold (4.65V for the MAX691A/MAX800L, 4.4V for the MAX693A/MAX800M) and remain asserted for 200ms typ after V<sub>CC</sub> rises above the reset threshold on power-up (Figure 5). The devices' battery-switchover comparator does not affect reset assertion. However, both reset outputs are asserted in battery-backup mode since V<sub>CC</sub> must be below the reset threshold to enter this mode.

### Watchdog Function

The watchdog monitors  $\mu$ P activity via the Watchdog Input (WDI). If the  $\mu$ P becomes inactive, RESET and RESET are asserted. To use the watchdog function, connect WDI to a bus line or  $\mu$ P I/O line. If WDI remains high or low for longer than the watchdog timeout period (1.6sec nominal), WDO, RESET, and RESET are asserted (see *RESET and RESET Outputs* section, and the *Watchdog Output* discussion on this page).

### Watchdog Input

A change of state (high to low, low to high, or a minimum 100ns pulse) at the Watchdog Input (WDI) during the watchdog period resets the watchdog timer. The watchdog default timeout is 1.6sec.

To disable the watchdog function, leave WDI floating. An internal resistor network (100k $\Omega$  equivalent impedance at WDI) blases WDI to approximately 1.6V. Internal comparators detect this level and disable the watchdog timer. When  $V_{CC}$  is below the reset threshold, the watchdog function is disabled and WDI is disconnected from its internal resistor network, thus becoming high impedance.

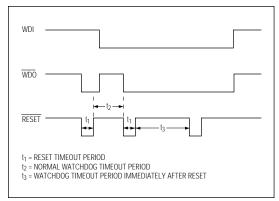


Figure 2. Watchdog Timeout Period and Reset Active Time

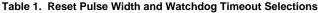
### Watchdog Output

The Watchdog Output (WDO) remains high if there is a transition or pulse at WDI during the watchdog timeout period. The watchdog function is disabled and WDO is a logic high when  $V_{CC}$  is below the reset threshold, battery-backup mode is enabled, or WDI is an open circuit. In watchdog mode, if no transition occurs at WDI during the watchdog timeout period, RESET and RESET are asserted for the reset timeout period (200ms typical). WDO goes low and remains low until the next transition at WDI (Figure 2). If WDI is held high or low indefinitely, RESET and RESET will generate 200ms pulses every 1.6sec. WDO has a 2 x TTL output characteristic.

### Selecting an Alternative Watchdog and Reset Timeout Period

The OSC SEL and OSC IN inputs control the watchdog and reset timeout periods. Floating OSC SEL and OSC IN or tying them both to V<sub>OUT</sub> selects the nominal 1.6sec watchdog timeout period and 200ms reset timeout period. Connecting OSC IN to GND and floating or connecting OSC SEL to  $V_{OUT}$  selects the 100ms normal watchdog timeout delay and 1.6sec delay immediately after reset. The reset timeout delay remains 200ms (Figure 2). Select alternative timeout periods by connecting OSC SEL to GND and connecting a capacitor between OSC IN and GND, or by externally driving OSC IN (Table 1 and Figure 3). OSC IN is internally connected to a ±100nA (typ) current source that charges and discharges the timing capacitor to create the oscillator frequency, which sets the reset and watchdog timeout periods (see Connecting a Timing Capacitor at OSC IN in the Applications Information section).

OSC SEL	L OSC IN Watchdog Timeout Period		Reset Timeout Period	
USC SEL	030 11	Normal	Immediately After Reset	Reset Timeout Periou
Low	External Clock Input	1024 clks	4096 clks	2048 clks
Low	External Capacitor	(600/47pF x C)ms	(2.4/47pF x C)sec	(1200/47pF x C)ms
Floating	Low	100ms	1.6sec	200ms
Floating	Floating	1.6sec	1.6sec	200ms



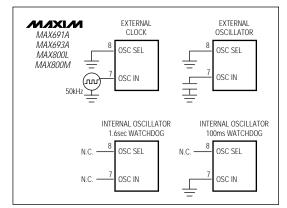


Figure 3. Oscillator Circuits

### Chip-Enable Signal Gating

The MAX691A/MAX693A/MAX800L/MAX800M provide internal gating of chip-enable (CE) signals to prevent erroneous data from being written to CMOS RAM in the event of a power failure. During normal operation, the CE gate is enabled and passes all CE transitions. When reset is asserted, this path becomes disabled, preventing erroneous data from corrupting the CMOS RAM. All these parts use a series transmission gate from CE IN to CE OUT (Figure 4).

The 10ns max CE propagation delay from  $\overline{CE}$  IN to  $\overline{CE}$  OUT enables the parts to be used with most µPs.

### Chip-Enable Input

The Chip-Enable Input (CE IN) is high impedance (disabled mode) while RESET and RESET are asserted.

During a power-down sequence where  $V_{CC}$  falls below the reset threshold or a watchdog fault,  $\overline{CE}$  IN assumes a high-impedance state when the voltage at  $\overline{CE}$  IN goes high or 15µs after reset is asserted, whichever occurs first (Figure 5).

During a power-up sequence,  $\overline{CE}$  IN remains high impedance, regardless of  $\overline{CE}$  IN activity, until reset is deasserted following the reset timeout period.

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In the high-impedance mode, the leakage currents into this terminal are  $\pm 1\mu A$  max over temperature. In the low-impedance mode, the impedance of  $\overline{CE}$  IN appears as a 75 $\Omega$  resistor in series with the load at  $\overline{CE}$  OUT.

The propagation delay through the CE transmission gate depends on both the source impedance of the drive to CE IN and the capacitive loading on the Chip-Enable Output (CE OUT) (see Chip-Enable Propagation Delay vs. CE OUT Load Capacitance in the *Typical Operating Characteristics*). The CE propagation delay is production tested from the 50% point of CE IN to the 50% point of CE OUT using a 50 $\Omega$  driver and 50pF of load capacitance (Figure 6). For minimum propagation delay, minimize the capacitive load at CE OUT, and use a low output-impedance driver.

### Chip-Enable Output

In the enabled mode, the impedance of  $\overline{\text{CE}}$  OUT is equivalent to 75 $\Omega$  in series with the source driving  $\overline{\text{CE}}$  IN. In the disabled mode, the 75 $\Omega$  transmission gate is off and  $\overline{\text{CE}}$  OUT is actively pulled to V<sub>OUT</sub>. This source turns off when the transmission gate is enabled.

### **LOW LINE** Output

 $\label{eq:low_line} \begin{array}{l} \hline \mbox{LOW LINE} \mbox{ is the buffered output of the reset threshold} \\ \mbox{comparator. } \hline \mbox{LOW LINE} \mbox{ typically sinks 3.2mA at 0.1V}. \\ \hline \mbox{For normal operation (V}_{CC} \mbox{ above the } \hline \mbox{LOW LINE} \mbox{ threshold}, \\ \hline \mbox{LOW LINE} \mbox{ is pulled to V}_{OUT}. \end{array}$ 

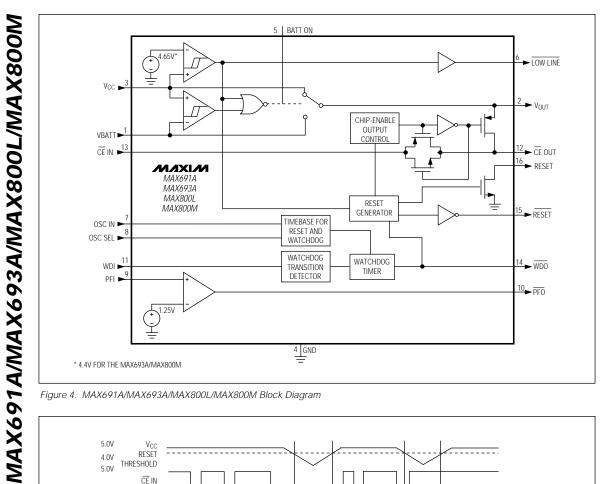
### **Power-Fail Comparator**

The power-fail comparator is an uncommitted comparator that has no effect on the other functions of the IC. Common uses include low-battery indication (Figure 7), and early power-fail warning (see *Typical Operating Circuit*).

### Power-Fail Input

PFI is the input to the power-fail comparator. PFI has a guaranteed input leakage of ±25nA max over temperature. The typical comparator delay is 25µs from V<sub>IL</sub> to V<sub>OL</sub> (power failing), and 60µs from V<sub>IH</sub> to V<sub>OH</sub> (power being restored). If unused, connect this input to ground.





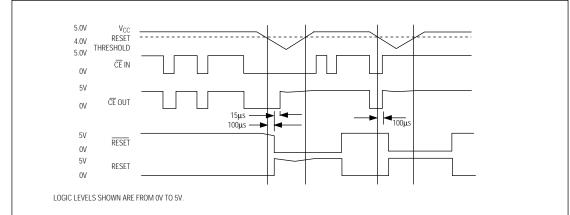


Figure 5. Reset and Chip-Enable Timing



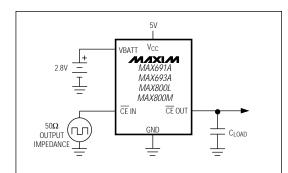


Figure 6. CE Propagation Delay Test Circuit

Table 2.	Input and	Output Status	in Battery-Backup
Mode			

Noue				
PIN	NAME	STATUS		
1	VBATT	Supply Current is 1µA max.		
2	Vout	VOUT is connected to VBATT through an internal PMOS switch.		
3	V <sub>CC</sub>	Battery switchover comparator monitors V <sub>CC</sub> for active switchover.		
4	GND	GND 0V, 0V reference for all signals.		
5	BATT ON	Logic high. The open-circuit output is equal to V <sub>OUT</sub> .		
6	LOWLINE	Logic Low*		
7	OSC IN	OSC IN is ignored.		
8	OSC SEL	OSC SEL is ignored.		
9	PFI	The power-fail comparator remains active in the battery-backup mode for $V_{CC} \ge VBATT - 1.2V$ typ.		
10	PFO	The power-fail comparator remains active in the battery-backup mode for $V_{CC} \ge VBATT - 1.2V$ typ. Below this volt- age, PFO is forced low.		
11	WDI	Watchdog is ignored.		
12	CE OUT	Logic high. The open-circuit voltage is equal to VOUT.		
13	CE IN	High Impedance.		
14	WDO	Logic high. The open-circuit voltage is equal to VOUT.		
15	RESET	Logic low*		
16	RESET	High Impedance*		

\*  $V_{\it CC}$  must be below the reset threshold to enter battery-backup mode.

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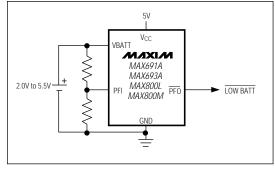


Figure 7. Low-Battery Indicator

### Power-Fail Output

The Power-Fail Output (PFO) goes low when PFI goes below 1.25V. It typically sinks 3.2mA with a saturation voltage of 0.1V. With PFI above 1.25V, PFO is actively pulled to  $V_{OUT}.$ 

### **Battery-Backup Mode**

Two conditions are required to switch to battery-backup mode: 1)  $V_{CC}$  must be below the reset threshold, and 2)  $V_{CC}$  must be below VBATT. Table 2 lists the status of the inputs and outputs in battery-backup mode.

### **Battery On Output**

The Battery On (BATT ON) output indicates the status of the internal  $V_{CC}$ /battery-switchover comparator, which controls the internal  $V_{CC}$  and VBATT switches. For  $V_{CC}$  greater that VBATT (ignoring the small hysteresis effect), BATT ON typically sinks 3.2mA at 0.1V saturation voltage. In battery-backup mode, this terminal sources approximately 10µA from  $V_{OUT}$ . Use BATT ON to indicate battery-switchover status or to supply base drive to an external pass transistor for higher-current applications (see *Typical Operating Circuit*).

### Input Supply Voltage

The Input Supply Voltage (V<sub>CC</sub>) should be a regulated 5V. V<sub>CC</sub> connects to V<sub>OUT</sub> via a parallel diode and a large PMOS switch. The switch carries the entire current load for currents less than 250mA. The parallel diode carries any current in excess of 250mA. Both the switch and the diode have impedances less than 1 $\Omega$  each. The maximum continuous current is 250mA, but power-on transients may reach a maximum of 1A.

### Backup-Battery Input

The Backup-Battery Input (VBATT) is similar to the  $V_{CC}$  input except the PMOS switch and parallel diode are much smaller. Accordingly, the on-resistances of the diode and the switch are each approximately 10 $\Omega$ . Continuous current should be limited to 25mA and peak currents (only during power-up) limited to 250mA. The reverse leakage of this input is less than 1µA over temperature and supply voltage (Figure 8).

### **Output Supply Voltage**

The Output Supply Voltage (V<sub>OUT</sub>) pin is internally connected to the substrate of the IC and supplies current to the external system and internal circuitry. All opencircuit outputs will, for example, assume the V<sub>OUT</sub> voltage in their high states rather than the V<sub>CC</sub> voltage. At the maximum source current of 250mA, V<sub>OUT</sub> will typically be 200mV below V<sub>CC</sub>. Decouple this terminal with a 0.1µF capacitor.

### \_Applications Information

The MAX691A/MAX693A/MAX800L/MAX800M are not short-circuit protected. Shorting  $V_{OUT}$  to ground, other than power-up transients such as charging a decoupling capacitor, destroys the device.

All open-circuit outputs swing between  $V_{\mbox{OUT}}$  and GND rather than  $V_{\mbox{CC}}$  and GND.

If long leads connect to the chip inputs, insure that these leads are free from ringing and other conditions that would forward bias the chip's protection diodes.

There are three distinct modes of operation:

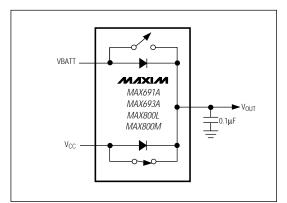


Figure 8. V<sub>CC</sub> and VBATT to V<sub>OUT</sub> Switch

- 1) Normal operating mode with all circuitry powered up. Typical supply current from  $V_{CC}$  is 35µA while only leakage currents flow from the battery.
- Battery-backup mode where V<sub>CC</sub> is typically within 0.7V below VBATT. All circuitry is powered up and the supply current from the battery is typically less than 60µA.
- 3) Battery-backup mode where  $V_{CC}$  is less than VBATT by at least 0.7V. VBATT supply current is 1µA max.

# Using SuperCaps or MaxCaps with the MAX691A/MAX693A/MAX800L/MAX800M

VBATT has the same operating voltage range as  $V_{CC}$ , and the battery switchover threshold voltages are typically ±30mV centered at VBATT, allowing use of a SuperCap and a simple charging circuit as a backup source (Figure 9).

If  $V_{CC}$  is above the reset threshold and VBATT is 0.5V above  $V_{CC}$ , current flows to  $V_{OUT}$  and  $V_{CC}$  from VBATT until the voltage at VBATT is less than 0.5V above  $V_{CC}$ . For example, with a SuperCap connected to VBATT and through a diode to  $V_{CC}$ , if  $V_{CC}$  quickly changes from 5.4V to 4.9V, the capacitor discharges through  $V_{OUT}$  and  $V_{CC}$  until VBATT reaches 5.1V typ. Leakage current through the SuperCap charging diode and the internal power diode eventually discharges the SuperCap to  $V_{CC}$ . Also, if  $V_{CC}$  and VBATT start from 0.1V above the reset threshold and power is lost at  $V_{CC}$ , the SuperCap on VBATT discharges through  $V_{CC}$  until VBATT reaches the reset threshold: then the battery-backup mode is initiated and the current through  $V_{CC}$  goes to zero.

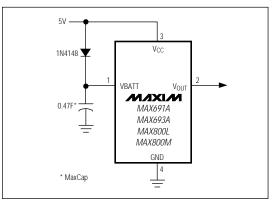


Figure 9. SuperCap or MaxCap on VBATT

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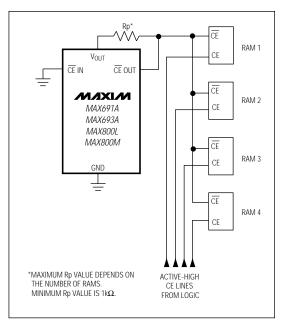


Figure 10. Alternate CE Gating

### Using Separate Power Supplies for VBATT and V<sub>CC</sub>

If using separate power supplies for V<sub>CC</sub> and VBATT, VBATT must be less than 0.3V above V<sub>CC</sub> when V<sub>CC</sub> is above the reset threshold. As described in the previous section, if VBATT exceeds this limit and power is lost at V<sub>CC</sub>, current flows continuously from VBATT to V<sub>CC</sub> via the VBATT-to-V<sub>OUT</sub> diode and the V<sub>OUT</sub>-to-V<sub>CC</sub> switch until the circuit is broken (Figure 8).

### Alternative Chip-Enable Gating

Using memory devices with both CE and  $\overline{CE}$  inputs allows the CE loop to be bypassed. To do this, connect  $\overline{CE}$  IN to ground, pull-up  $\overline{CE}$  OUT to  $V_{OUT}$ , and connect  $\overline{CE}$  OUT to the  $\overline{CE}$  input of each memory device (Figure 10). The CE input of each part then connects directly to the chip-select logic, which does not have to be gated.

### Adding Hysteresis to the Power-Fail Comparator

Hysteresis adds a noise margin to the power-fail comparator and prevents repeated triggering of  $\overline{\text{PFO}}$  when  $V_{\text{IN}}$  is near the power-fail comparator trip point. Figure 11 shows how to add hysteresis to the power-fail com-

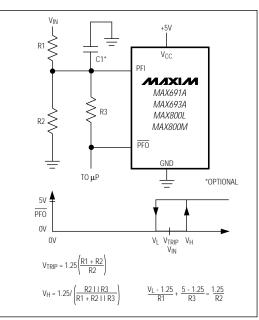


Figure 11. Adding Hysteresis to the Power-Fail Comparator

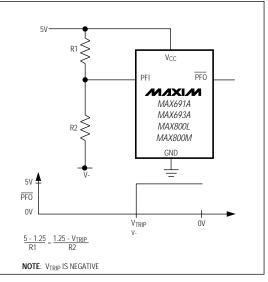


Figure 12. Monitoring a Negative Voltage

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MAX691A/MAX693A/MAX800L/MAX800M

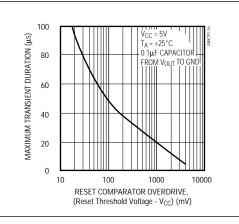


Figure 13. Maximum Transient Duration without Causing a Reset Pulse vs. Reset Comparator Overdrive

parator. Select the ratio of R1 and R2 such that PFI sees 1.25V when V<sub>IN</sub> falls to the desired trip point (V<sub>TRIP</sub>). Resistor R3 adds hysteresis. It will typically be an order of magnitude greater than R1 or R2. The current through R1 and R2 should be at least 1µA to ensure that the 25nA (max) PFI input current does not shift the trip point. R3 should be larger than 10kΩ to prevent it from loading down the  $\overline{PFO}$  pin. Capacitor C1 adds additional noise rejection.

### Monitoring a Negative Voltage

The power-fail comparator can be used to monitor a negative supply voltage using Figure 12's circuit. When the negative supply is valid,  $\overrightarrow{PFO}$  is low. When the negative supply voltage drops,  $\overrightarrow{PFO}$  goes high. This circuit's accuracy is affected by the PFI threshold tolerance, the V<sub>CC</sub> voltage, and resistors R1 and R2.

### **Backup-Battery Replacement**

The backup battery may be disconnected while  $V_{CC}$  is above the reset threshold. No precautions are necessary to avoid spurious reset pulses.

### Negative-Going V<sub>CC</sub> Transients

While issuing resets to the  $\mu P$  during power-up, powerdown, and brownout conditions, these supervisors are relatively immune to short-duration, negative-going V<sub>CC</sub> transients (glitches). It is usually undesirable to reset the  $\mu P$  when V<sub>CC</sub> experiences only small glitches.

Figure 7 shows maximum transient duration vs. resetcomparator overdrive, for which reset pulses are **not** generated. The graph was produced using negativegoing V<sub>CC</sub> pulses, starting at 5V and ending below the reset threshold by the magnitude indicated (reset comparator overdrive). The graph shows the maximum pulse width a negative-going V<sub>CC</sub> transient may typically have without causing a reset pulse to be issued. As the amplitude of the transient increases (i.e., goes farther below the reset threshold), the maximum allowable pulse width decreases. Typically, a V<sub>CC</sub> transient that goes 100mV below the reset threshold and lasts for 40µs or less will not cause a reset pulse to be issued.

A 100nF bypass capacitor mounted close to the  $\rm V_{\rm CC}$  pin provides additional transient immunity.

**Connecting a Timing Capacitor at OSC IN** When OSC SEL is connected to ground, OSC IN disconnects from its internal 10µA (typ) pull-up and is internally connected to a  $\pm$ 100nA current source. When a capacitor is connected from OSC IN to ground (to select alternative reset and watchdog timeout periods), the current source charges and discharges the timing capacitor to create the oscillator that controls the reset and watchdog timeout period. To prevent timing errors or oscillator start-up problems, minimize external current leakage sources at this pin, and locate the capacitor as close to OSC IN as possible. The sum of PC-board leakage + OSC capacitor leakage must be small compared to  $\pm$ 100nA.

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### Maximum V<sub>CC</sub> Fall Time

The V<sub>CC</sub> fall time is limited by the propagation delay of the battery switchover comparator and should not exceed 0.03V/µs. A standard rule of thumb for filter capacitance on most regulators is on the order of 100µF per amp of current. When the power supply is shut off or the main battery is disconnected, the associated initial V<sub>CC</sub> fall rate is just the inverse or 1A/100µF = 0.01V/µs. The V<sub>CC</sub> fall rate decreases with time as V<sub>CC</sub> falls exponentially, which more than satisfies the maximum fall-time requirement.

Watchdog Software Considerations A way to help the watchdog timer keep a closer watch on software execution involves setting and resetting the watchdog input at different points in the program, rather than "pulsing" the watchdog input high-low-high or low-high-low. This technique avoids a "stuck" loop where the watchdog timer continues to be reset within the loop, keeping the watchdog from timing out. Figure 14 shows an example flow diagram where the I/O driving the watchdog input is set high at the beginning of the program, set low at the beginning of every subroutine or loop, then set high again when the program returns to the beginning. If the program should "hang" in any subroutine, the I/O is continually set low and the watchdog timer is allowed to time out, causing a reset or interrupt to be issued.

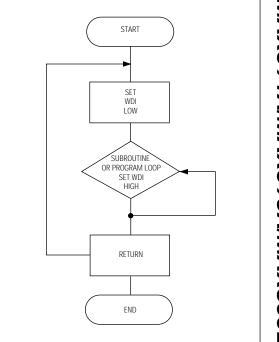
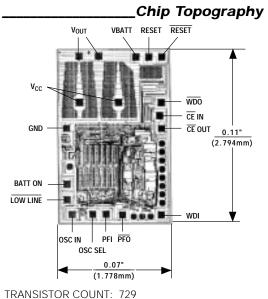


Figure 14. Watchdog Flow Diagram

MAX691A/MAX693A/MAX800L/MAX800M

		n (continued
PART	TEMP. RANGE	PIN-PACKAGE
MAX693ACPE	0°C to +70°C	16 Plastic DIP
MAX693ACSE	0°C to +70°C	16 Narrow SO
MAX693ACWE	0°C to +70°C	16 Wide SO
MAX693AC/D	0°C to +70°C	Dice*
MAX693AEPE	-40°C to +85°C	16 Plastic SO
MAX693AESE	-40°C to +85°C	16 Narrow SO
MAX693AEWE	-40°C to +85°C	16 Wide SO
MAX693AEJE	-40°C to +85°C	16 CERDIP
MAX693AMJE	-55°C to +125°C	16 CERDIP
MAX800LCPE	0°C to +70°C	16 Plastic DIP
MAX800LCSE	0°C to +70°C	16 Narrow SO
MAX800LEPE	-40°C to +85°C	16 Plastic DIP
MAX800LESE	-40°C to +85°C	16 Narrow SO
MAX800MCPE	0°C to +70°C	16 Plastic DIP
MAX800MCSE	0°C to +70°C	16 Narrow SO
MAX800MEPE	-40°C to +85°C	16 Plastic DIP
MAX800MESE	-40°C to +85°C	16 Narrow SO

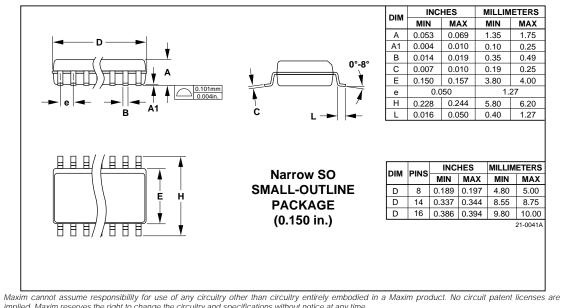
\* Dice are specified at  $T_A = +25^{\circ}C$ , DC parameters only.



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